Höchstzulässige Werte / Maximum rated values

Elektrische Eigenschaften / Electrical properties

Kollektor-Emitter-Sperrspannung collector-emitter voltage		V_{CES}	1200	V
Kollektor-Dauergleichstrom DC-collector current	T_C = 70 °C T_C = 25 °C	$I_{C,nom.}$ I_C	100 150	A A
Periodischer Kollektor Spitzenstrom repetitive peak collector current	t_P = 1 ms, T_C = 80°C	I_{CRM}	200	A
Gesamt-Verlustleistung total power dissipation	T_C=25°C, Transistor	P_{tot}	0,78	kW
Gate-Emitter-Spitzenspannung gate-emitter peak voltage		V_{GES}	+/- 20V	V
Dauergleichstrom DC forward current		I_F	100	A
Periodischer Spitzenstrom repetitive peak forw. current	t_P = 1 ms	I_{FRM}	200	A
Grenzlastintegral der Diode I^2t - value, Diode	V_R = 0V, t_p = 10ms, T_{vj} = 125°C	I^2t	4.000	A^2s
Isolations-Prüfspannung insulation test voltage	RMS, f = 50 Hz, t = 1 min.	V_{ISOL}	2,5	kV

Charakteristische Werte / Characteristic values

Transistor / Transistor

			min.	typ.	max.	
Kollektor-Emitter Sättigungsspannung collector-emitter saturation voltage	I_C = 100A, V_{GE} = 15V, T_{vj} = 25°C I_C = 100A, V_{GE} = 15V, T_{vj} = 125°C	$V_{CE\,sat}$	- -	3,2 3,85	3,7 -	V V
Gate-Schwellenspannung gate threshold voltage	I_C = 4mA, V_{CE} = V_{GE}, T_{vj} = 25°C	$V_{GE(th)}$	4,5	5,5	6,5	V
Gateladung gate charge	V_{GE} = -15V...+15V	Q_G	-	1,1	-	µC
Eingangskapazität input capacitance	f = 1MHz,T_{vj} = 25°C,V_{CE} = 25V, V_{GE} = 0V	C_{ies}	-	6,5	-	nF
Rückwirkungskapazität reverse transfer capacitance	f = 1MHz,T_{vj} = 25°C,V_{CE} = 25V, V_{GE} = 0V	C_{res}	-	0,42	-	nF
Kollektor-Emitter Reststrom collector-emitter cut-off current	V_{CE} = 1200V, V_{GE} = 0V, T_{vj} = 25°C	I_{CES}	-	-	5	mA
Gate-Emitter Reststrom gate-emitter leakage current	V_{CE} = 0V, V_{GE} = 20V, T_{vj} = 25°C	I_{GES}	-	-	400	nA

prepared by: A.Schulz	date of publication: 2001-11-29
approved by: M.Hierholzer	revision: 2

Charakteristische Werte / Characteristic values

Transistor / Transistor			min.	typ.	max.	
Einschaltverzögerungszeit (ind. Last) turn on delay time (inductive load)	I_C = 100A, V_{CE} = 600V					
	V_{GE} = ±15V, R_G = 9,1Ω, T_{vj} = 25°C	$t_{d,on}$	-	100	-	ns
	V_{GE} = ±15V, R_G = 9,1Ω, T_{vj} = 125°C		-	125	-	ns
Anstiegszeit (induktive Last) rise time (inductive load)	I_C = 100A, V_{CE} = 600V					
	V_{GE} = ±15V, R_G = 9,1Ω, T_{vj} = 25°C	t_r	-	90	-	ns
	V_{GE} = ±15V, R_G = 9,1Ω, T_{vj} = 125°C		-	100	-	ns
Abschaltverzögerungszeit (ind. Last) turn off delay time (inductive load)	I_C = 100A, V_{CE} = 600V					
	V_{GE} = ±15V, R_G = 9,1Ω, T_{vj} = 25°C	$t_{d,off}$	-	530	-	ns
	V_{GE} = ±15V, R_G = 9,1Ω, T_{vj} = 125°C		-	590	-	ns
Fallzeit (induktive Last) fall time (inductive load)	I_C = 100A, V_{CE} = 600V					
	V_{GE} = ±15V, R_G = 9,1Ω, T_{vj} = 25°C	t_f	-	60	-	ns
	V_{GE} = ±15V, R_G = 9,1Ω, T_{vj} = 125°C		-	70	-	ns
Einschaltverlustenergie pro Puls turn-on energy loss per pulse	I_C = 100A, V_{CE} = 600V, V_{GE} = 15V					
	R_G = 9,1Ω, T_{vj} = 125°C, L_S = 60nH	E_{on}	-	9,5	-	mWs
Abschaltverlustenergie pro Puls turn-off energy loss per pulse	I_C = 100A, V_{CE} = 600V, V_{GE} = 15V					
	R_G = 9,1Ω, T_{vj} = 125°C, L_S = 60nH	E_{off}	-	7,7	-	mWs
Kurzschlußverhalten SC Data	t_P ≤ 10µsec, V_{GE} ≤ 15V, R_G = 9,1Ω					
	T_{vj}≤125°C, V_{CC}=900V, V_{CEmax}=V_{CES} -L_{sCE} ·dI/dt	I_{SC}	-	650	-	A
Modulinduktivität stray inductance module		L_{sCE}	-	25	-	nH
Modul Leitungswiderstand, Anschlüsse – Chip module lead resistance, terminals – chip	T_C=25°C	$R_{CC'+EE'}$	-	0,60	-	mΩ

Charakteristische Werte / Characteristic values

Diode / Diode			min.	typ.	max.	
Durchlaßspannung forward voltage	I_F = 100A, V_{GE} = 0V, T_{vj} = 25°C	V_F	-	2,0	2,4	V
	I_F = 100A, V_{GE} = 0V, T_{vj} = 125°C		-	1,7	-	V
Rückstromspitze peak reverse recovery current	I_F = 100A, - di_F/dt = 1000A/µsec					
	V_R = 600V, VGE = -15V, T_{vj} = 25°C	I_{RM}	-	68	-	A
	V_R = 600V, VGE = -15V, T_{vj} = 125°C		-	110	-	A
Sperrverzögerungsladung recovered charge	I_F = 100A, - di_F/dt = 1000A/µsec					
	V_R = 600V, VGE = -15V, T_{vj} = 25°C	Q_r	-	7,5	-	µAs
	V_R = 600V, VGE = -15V, T_{vj} = 125°C		-	20,0	-	µAs
Abschaltenergie pro Puls reverse recovery energy	I_F = 100A, - di_F/dt = 1000A/µsec					
	V_R = 600V, VGE = -15V, T_{vj} = 25°C	E_{rec}	-	4,0	-	mWs
	V_R = 600V, VGE = -15V, T_{vj} = 125°C		-	9,5	-	mWs

Thermische Eigenschaften / Thermal properties

			min.	typ.	max.	
Innerer Wärmewiderstand	Transistor / transistor,DC , pro Modul / per module	R_{thJC}	-	-	0,08	K/W
thermal resistance, junction to case	Transistor / transistor,DC , pro Zweig / per arm		-	-	0,16	K/W
	Diode / Diode, DC, pro Modul / per module		-	-	0,15	K/W
	Diode / Diode, DC, pro Zweig / per arm		-	-	0,30	K/W
Übergangs-Wärmewiderstand	pro Modul / per module	R_{thCK}	-	0,01	-	K/W
thermal resistance, case to heatsink	pro Zweig / per arm		-	0,02	-	K/W
	λ_{Paste} = 1 W/m*K / λ_{grease} = 1 W/m*K					
Höchstzulässige Sperrschichttemperatur maximum junction temperature		$T_{vj\ max}$	-	-	150	°C
Betriebstemperatur operation temperature		$T_{vj\ op}$	-40	-	125	°C
Lagertemperatur storage temperature		T_{stg}	-40	-	150	°C

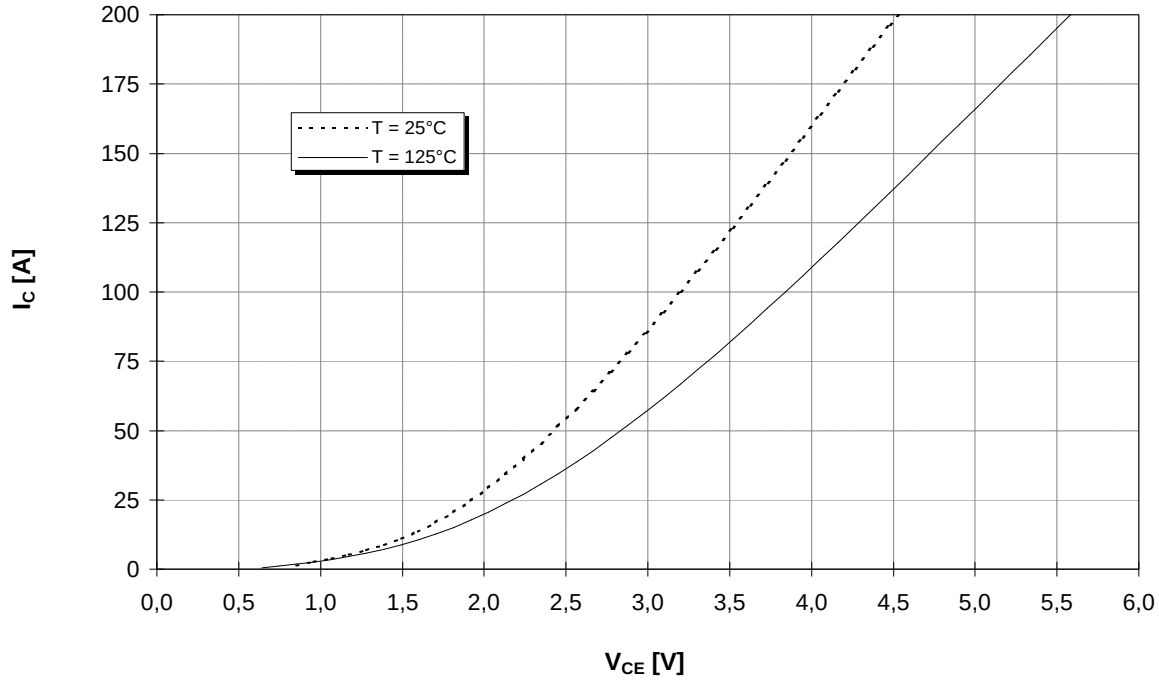
Mechanische Eigenschaften / Mechanical properties

Gehäuse, siehe Anlage case, see appendix						
Innere Isolation internal insulation				AL_2O_3		
Kriechstrecke creepage distance				20		mm
Luftstrecke clearance				11		mm
CTI comperative tracking index				275		
Anzugsdrehmoment f. mech. Befestigung mounting torque		M1	3		6	Nm
Anzugsdrehmoment f. elektr. Anschlüsse terminal connection torque	terminals M6	M2	2,5		5	Nm
Gewicht weight		G		420		g

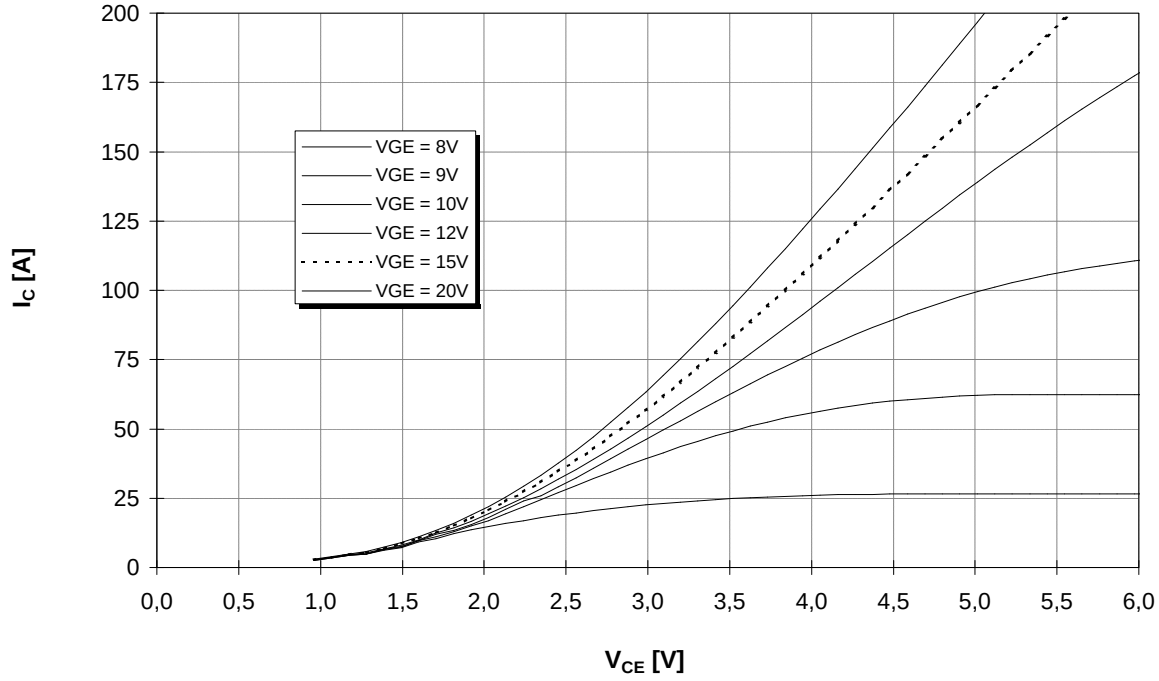
Mit dieser technischen Information werden Halbleiterbauelemente spezifiziert, jedoch keine Eigenschaften zugesichert. Sie gilt in Verbindung mit den zugehörigen Technischen Erläuterungen.

This technical information specifies semiconductor devices but promises no characteristics. It is valid in combination with the belonging technical notes.

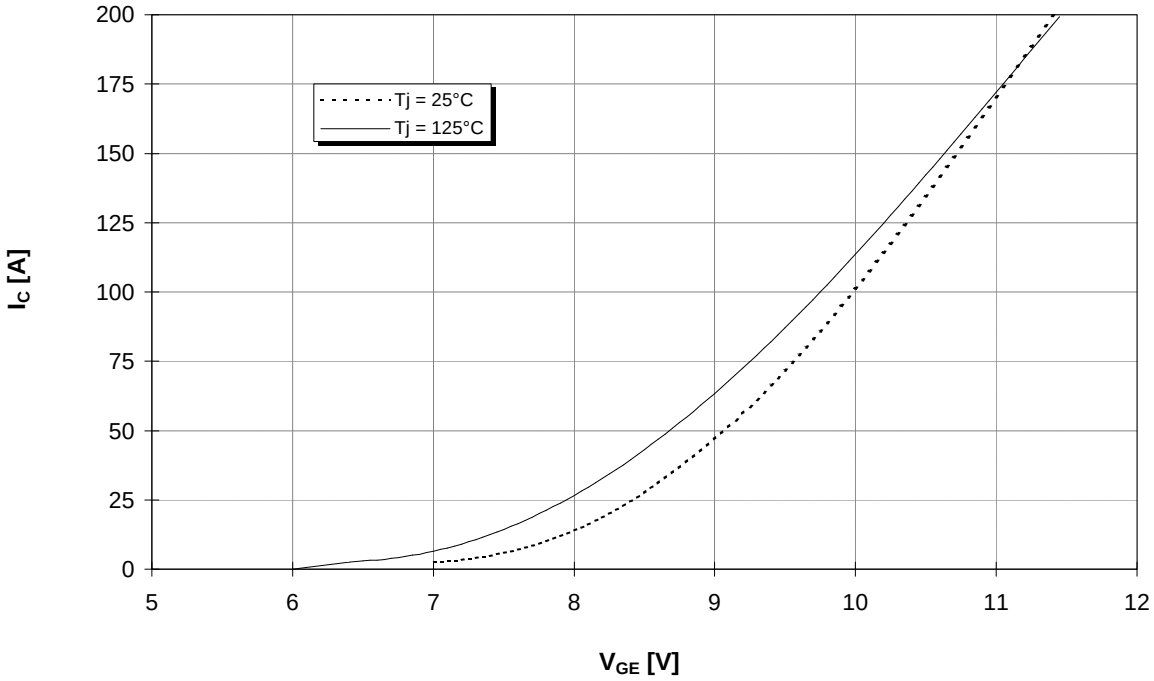
Ausgangskennlinie (typisch) $I_C = f(V_{CE})$
Output characteristic (typical) $V_{GE} = 15V$



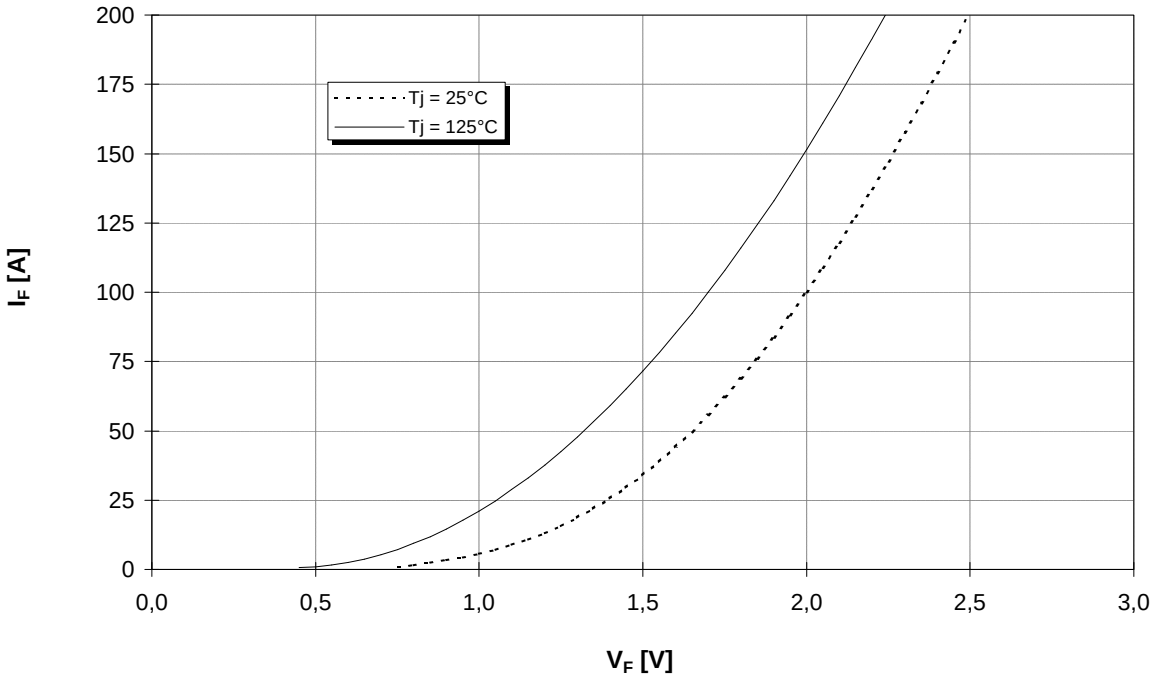
Ausgangskennlinienfeld (typisch) $I_C = f(V_{CE})$
Output characteristic (typical) $T_{vj} = 125°C$



Übertragungscharakteristik (typisch) $I_C = f(V_{GE})$
Transfer characteristic (typical) $V_{CE} = 20V$

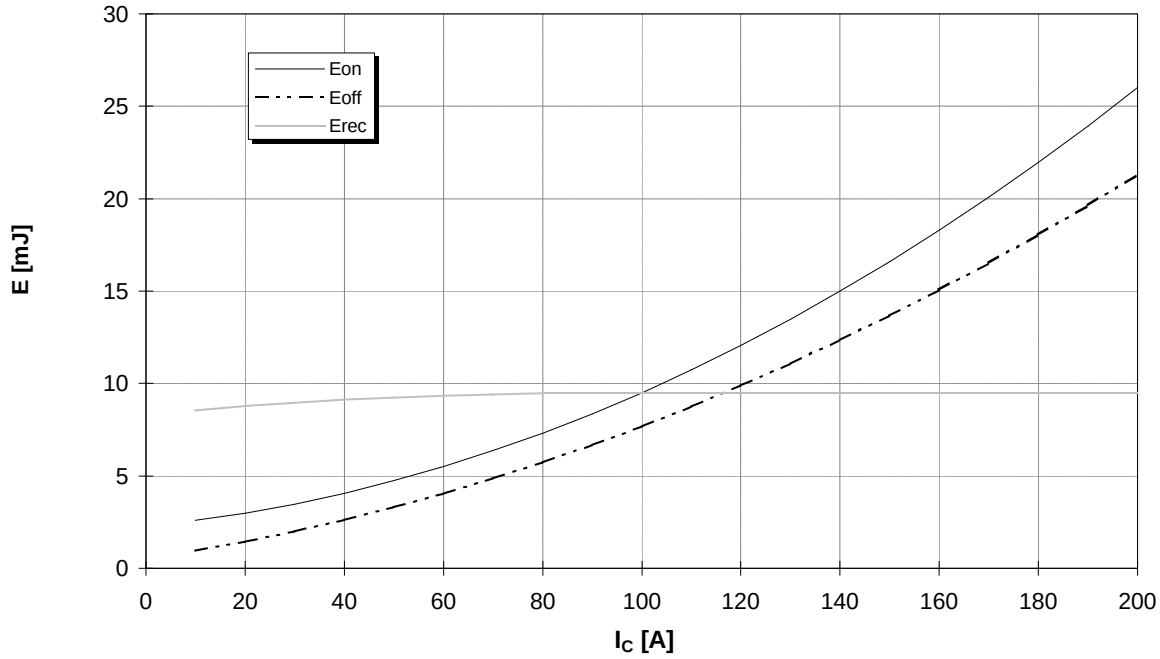


Durchlaßkennlinie der Inversdiode (typisch) $I_F = f(V_F)$
Forward characteristic of inverse diode (typical)



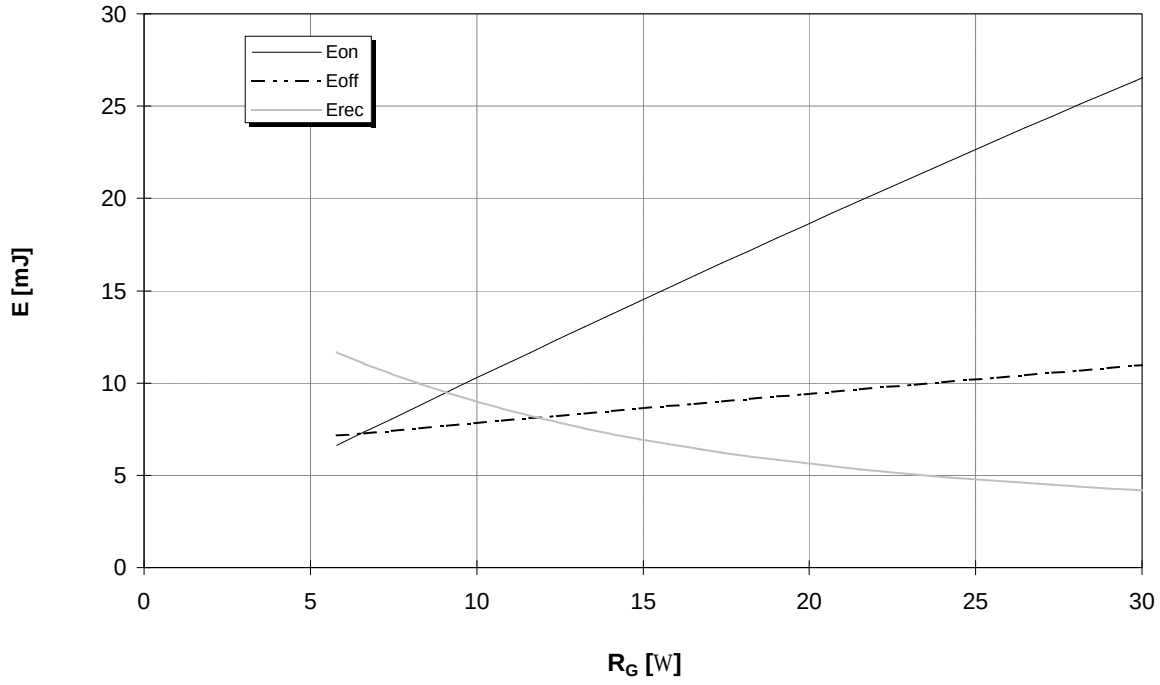
Schaltverluste (typisch) $E_{on} = f(I_C)$, $E_{off} = f(I_C)$, $E_{rec} = f(I_C)$

Switching losses (typical) V_{GE}=15V, $R_{gon} = R_{goff}$ =9,1 Ω, V_{CE} = 600V, T_j = 125°C

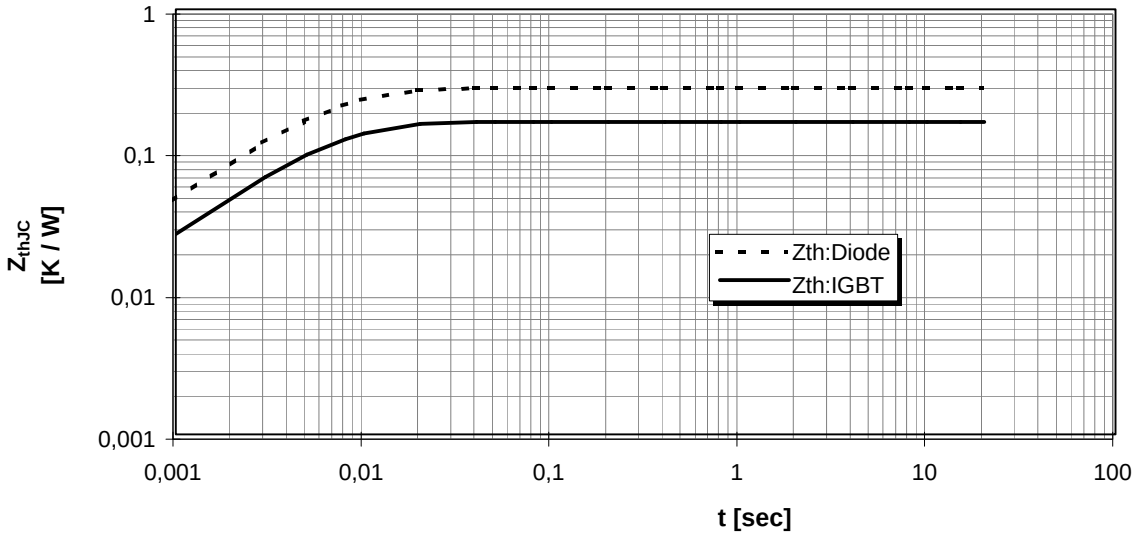


Schaltverluste (typisch) $E_{on} = f(R_G)$, $E_{off} = f(R_G)$, $E_{rec} = f(R_G)$

Switching losses (typical) V_{GE}=15V , I_C = 100A , V_{CE} = 600V , T_j = 125°C

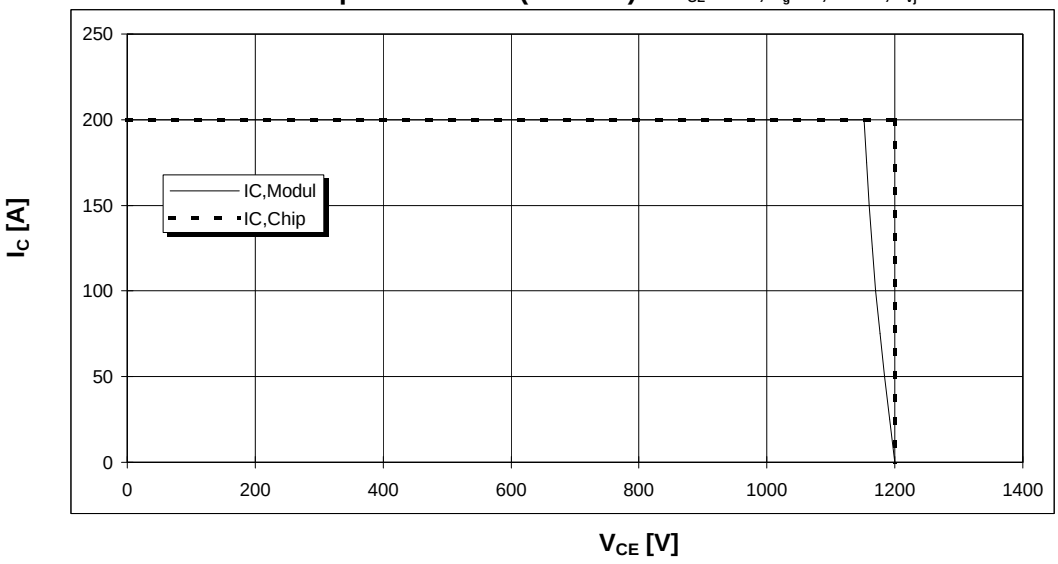


Transienter Wärmewiderstand $Z_{thJC} = f(t)$
Transient thermal impedance



i		1	2	3	4
r_i [K/kW]	: IGBT	71,26	54,24	34,43	0,06
τ_i [sec]	: IGBT	0,006	0,029	0,043	1,014
r_i [K/kW]	: Diode	81,89	122,02	63,19	32,9
τ_i [sec]	: Diode	0,006	0,035	0,033	0,997

Sicherer Arbeitsbereich (RBSOA)
Reverse bias safe operation area (RBSOA) V_{GE} = 15V, R_g = 9,1 Ohm, T_{vj}= 125°C



Gehäusemaße / Schaltbild
Package outline / Circuit diagram